

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/654,274	MIYAJIMA ET AL.	
Examiner	Art Unit	
Charles N. Appiah	2617	

SEARCHED					
Class	Subclass	Date	Examiner		
455	127.1,126. 1,161.3,18 4.1,232.1,	5/15/2006	CA		
	240.1,				
	234.1				
	250.1				
	245.1,				
	251.1				
	239.1				
375	345,222				
	260				
330	128,129,				
	254,278				
331	128				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
See at	tached	5/15/2006			

SEARCH I (INCLUDING SEAR		<b>'</b> )
	DATE	EXMR
455/subclasses updated	5/15/2006	CA
375/345,222,260		
330/128,129,254,278		
331/128		
EPO,Derwent, JPO		